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Relevance scale ☐ ☐ ☐ ☐ ☐**1** [Proceedings of the 2004 conference on Designing interactive systems: processes, practices, methods, and techniques](#)David Benyon, Paul Moody, Daniel Gruen, Irene McAra-McWilliam
August 2004 proceeding, ACM PressAdditional Information: [full citation](#), [abstract](#)

Welcome to DIS2004, the ACM conference on Designing Interactive Systems. We have a fantastic program of papers, posters, panels, lab tours, exhibits and design competition packed into three days. A veritable feast of the best examples of interactive systems design with some challenging and provocative views on the processes and theories of the design of interactive media. One of the key locations in the development of interactive media is the Massachusetts Institute of Technology, MIT and we are ...

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IEEE JNL IEE Journal or Magazine

IEEE CNF IEEE Conference Proceeding

IEEE CNF IEE Conference Proceeding

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